



FQD4N20 / FQU4N20

200V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

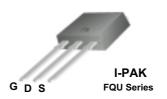
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supply, DC-AC converters for uninterrupted power supply, motor control.

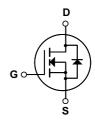
Features

- 3.0A, 200V, $R_{DS(on)}$ = 1.4 Ω @ V_{GS} = 10 V
- Low gate charge (typical 5.0 nC)
- Low Crss (typical 5.0 pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









Rev. A2, January 2009

Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQD4N20 / FQU4N20	Units
V _{DSS}	Drain-Source Voltage		200	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		3.0	Α
			1.95	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	12	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	52	mJ
I _{AR}	Avalanche Current	(Note 1)	3.0	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	3.0	mJ
dv/dt	Peak Diode Recovery dv/dt (N		5.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
	Power Dissipation (T _C = 25°C) - Derate above 25°C		30	W
			0.24	W/°C
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
R _{0JC} Thermal Resistance, Junction-to-Case			4.17	°C/W
$R_{\theta JA}$	θJA Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

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* When mounted on the minimum pad size recommended (PCB Mount)

	Parameter Test Conditions		Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature $I_D = 250 \mu A$, Referenced to 25°C Coefficient			0.24		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 200 V, V _{GS} = 0 V			1	μΑ
		V _{DS} = 160 V, T _C = 125°C		-	10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward V _{GS} = 30 V, V _{DS} = 0 V			-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	eakage Current, Reverse V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	racteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{C_2} = 10 \text{ V. } I_D = 1.5 \text{ A}$		1.12	1.4	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 1.5 A (Note 4)		1.85		S
Coss	Output Capacitance			35	45	pF
Ooss	Output Capacitance			33	45	
C _{rss}	Reverse Transfer Capacitance			5	7	рF
	Reverse Transfer Capacitance			5	7	
		Vpp = 100 V lp = 3 6 A		7	7 25	•
Switch	ing Characteristics	$V_{DD} = 100 \text{ V}, I_{D} = 3.6 \text{ A},$ $R_{G} = 25 \Omega$		-		pF
Switch	ing Characteristics Turn-On Delay Time	$R_G = 25 \Omega$		7	25	pF
Switch t _{d(on)} t _r t _{d(off)}	Ing Characteristics Turn-On Delay Time Turn-On Rise Time			7 50	25 110	pF ns
Switch td(on) tr td(off) tf Qg	Turn-On Rise Time Turn-Off Delay Time	$R_G = 25 \Omega$		7 50 7	25 110 25	ns ns
Switch t _{d(on)} t _r t _{d(off)}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	R_G = 25 Ω (Note 4, 5)		7 50 7 25	25 110 25 60	ns ns ns
$\begin{array}{c} \textbf{Switch} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \end{array}$	ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	R_G = 25 Ω (Note 4, 5) V_{DS} = 160 V, I_D = 3.6 A,	 	7 50 7 25 5.0	25 110 25 60 6.5	pF ns ns ns ns nc
$\begin{array}{c} \textbf{Switch} \\ t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	R_{G} = 25 Ω (Note 4, 5) V_{DS} = 160 V, I_{D} = 3.6 A, V_{GS} = 10 V (Note 4, 5)	 	7 50 7 25 5.0 1.4	25 110 25 60 6.5	ns ns ns nc nC
$\begin{array}{c} \textbf{Switch} \\ t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \\ Q_{g} \\ Q_{gs} \\ Q_{gd} \\ \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_G = 25~\Omega \end{tabular}$ (Note 4, 5) $V_{DS} = 160~V, I_D = 3.6~A, \end{tabular}$ (Note 4, 5) $V_{GS} = 10~V \end{tabular}$ (Note 4, 5)	 	7 50 7 25 5.0 1.4	25 110 25 60 6.5	ns ns ns nc nC
$\begin{array}{c} \textbf{Switch} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \\ \textbf{Drain-S} \end{array}$	Ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	R_G = 25 Ω (Note 4, 5) V_{DS} = 160 V, I_D = 3.6 A, V_{GS} = 10 V (Note 4, 5) and Maximum Ratings de Forward Current Forward Current	 	7 50 7 25 5.0 1.4 2.1	25 110 25 60 6.5 	ns ns ns ns nC
$\begin{array}{c} \textbf{Switch} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \\ \textbf{Drain-S} \\ \textbf{I}_{S} \\ \end{array}$	Ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics and Maximum Continuous Drain-Source Dio	$R_G = 25 \ \Omega$ (Note 4, 5) $V_{DS} = 160 \ V, I_D = 3.6 \ A,$ $V_{GS} = 10 \ V$ (Note 4, 5) $N_{CS} = 10 \ V$ (Note 4, 5) $N_{CS} = 10 \ V$		7 50 7 25 5.0 1.4 2.1	25 110 25 60 6.5 	ns ns ns ns nC nC
Switch td(on) tr td(off) tf Qg Qgs Qgd Drain-S	ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics au Maximum Continuous Drain-Source Diode	R_G = 25 Ω (Note 4, 5) V_{DS} = 160 V, I_D = 3.6 A, V_{GS} = 10 V (Note 4, 5) and Maximum Ratings de Forward Current Forward Current		7 50 7 25 5.0 1.4 2.1	25 110 25 60 6.5 3.0	ns ns ns nC nC nC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 8.7mH, I_{AS} = 3.0A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C 3. I_{SD} ≤ 3.6A, di/dt ≤ 300A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width ≤ 300 μ s, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

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Typical Characteristics

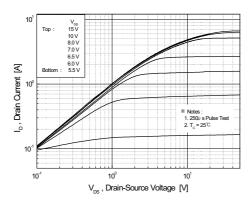


Figure 1. On-Region Characteristics

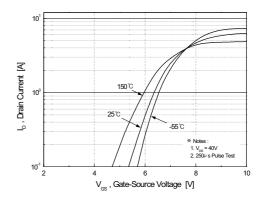


Figure 2. Transfer Characteristics

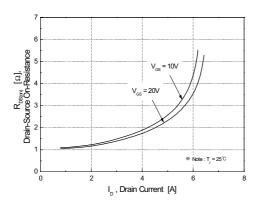


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

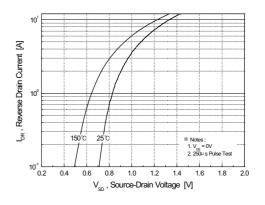


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

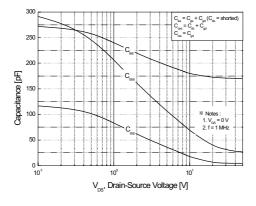


Figure 5. Capacitance Characteristics

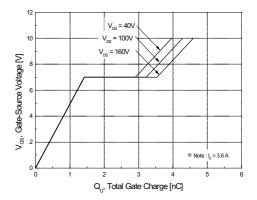


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

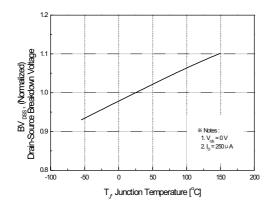
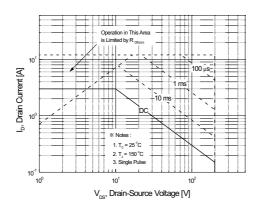


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



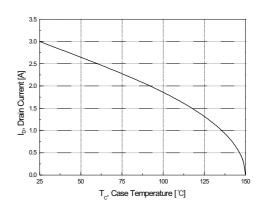


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

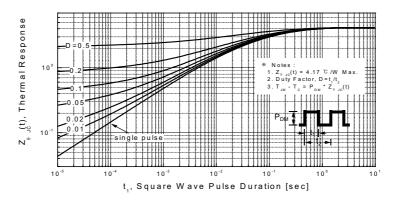
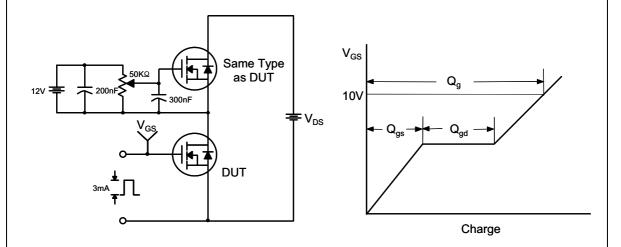
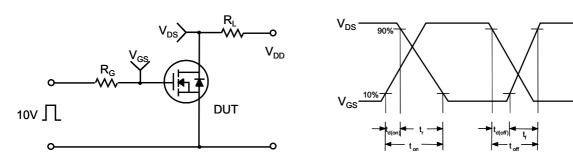


Figure 11. Transient Thermal Response Curve

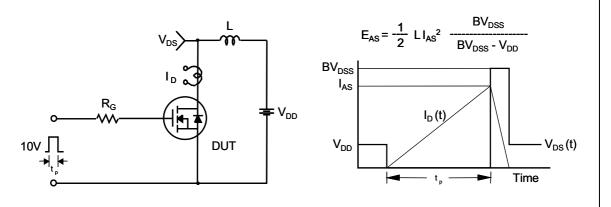
Gate Charge Test Circuit & Waveform



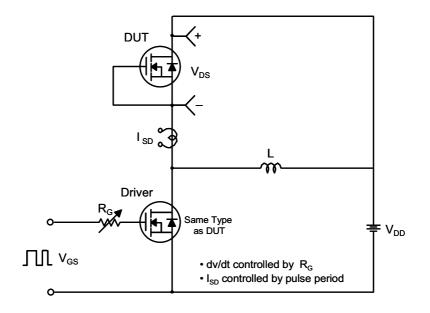
Resistive Switching Test Circuit & Waveforms

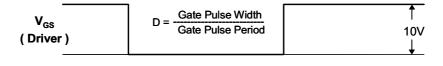


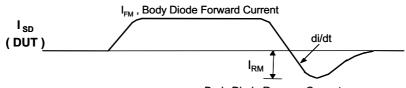
Unclamped Inductive Switching Test Circuit & Waveforms



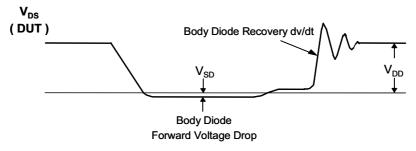
Peak Diode Recovery dv/dt Test Circuit & Waveforms







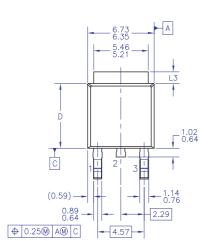
Body Diode Reverse Current

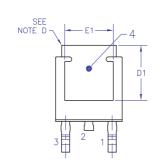


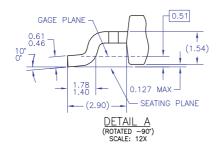
Package Dimensions

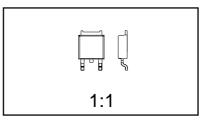
TO-252 (DPAK) (FS PKG Code 36)





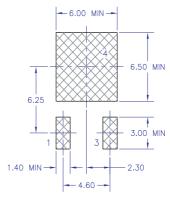




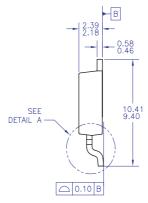


Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

Part Weight per unit (gram): 0.33



LAND PATTERN RECOMMENDATION



NOTES: UNLESS OTHERWISE SPECIFIED

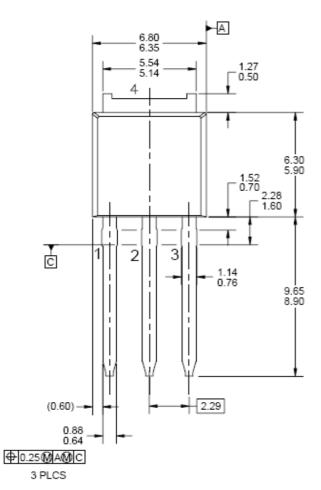
- UNLESS OTHERWISE SPECIFIED
 ALL DIMENSIONS ARE IN MILLIMETERS.
 THIS PACKAGE CONFORMS TO JEDEC, TO-252,
 ISSUE C, VARIATION AA & AB, DATED NOV. 1999.
 DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-1994.
 HEAT SINK TOP EDGE COULD BE IN CHAMFERED
 CORNERS OR EDGE PROTRUSION.
 DIMENSIONS L3,D,E1&D1 TABLE:

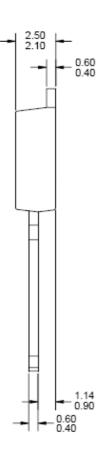
-			,
		OPTION AA	OPTION AB
	L3	0.89-1.27	1.52-2.03
	D	5.97-6.22	5.33-5.59
	E1	4.32 MIN	3.81 MIN
	D1	5.21 MIN	4.57 MIN

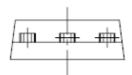
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I - PAK







Dimensions in Millimeters





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